



Docket No.: MUH-11449

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By: 

Date: September 18, 2003

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Gunnar Krause et al.
Applic. No. : 09/898,816
Filed : July 3, 2001
Title : Method and Device for Offset-Voltage Free Voltage
Measurement and Adjustment of a Reference Voltage Source
of an Integrated Semiconductor Circuit
Examiner : Vinh P. Nguyen - Art Unit: 2829

INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. 1.97(C)(2)

Hon. Commissioner for Patents

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

United States Patent No. 6,014,020 (Kuttner), dated January 11, 2000, which corresponds with previously filed German Published Non-Prosecuted Patent Application DE 197 35 381, dated January 14, 1999;

United States Patent No. 6,504,394 B2 (Ohlhoff), dated January 7, 2003, which corresponds with German Patent DE 199 60 244 C1, dated February 1, 2001.

In accordance with 37 C.F.R. 1.97 (c) (2), consideration of this Information Disclosure Statement is requested.

09/25/2003 TBESHAH1 00000008 09898816

01 FC:1806

180.00 OP

Enclosed is the fee in the amount of \$180.00.

Respectfully submitted,



For Applicants

Mark P. Weichselbaum
Reg. No. 43,248

Date: September 18, 2003

Lerner And Greenberg, P.A.
Post Office Box 2480
Hollywood, FL 33022-2480
Tel: (954) 925-1100
Fax: (954) 925-1101

/bmb

FORM PTO-1449 (SUBSTITUTE)

Attorney Docket No.:

Applic. No.

MUH-11449

09/898,816

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

Applicant

Gunnar Krause et al.

Filing Date

Group Art Unit

July 3, 2001

2829

INFORMATION DISCLOSURE
STATEMENT BY APPLICANT
(37 CFR 1.98(b))

U.S. PATENT DOCUMENTS

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A	6,014,020	01/11/00	Kuttner			
	B	6,504,394 B2	01/07/03	Ohlhoff			
	C						
	D						
	E						
	F						
	G						
	H						
	I						

FOREIGN PATENT DOCUMENT

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
	J	199 60 244 C1	02/01/01	Germany			
	K						
	L						
	M						
	N						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	O	
	P	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

